

62 mm module with TRENCHSTOP IGBT7 and emitter controlled 7 diode

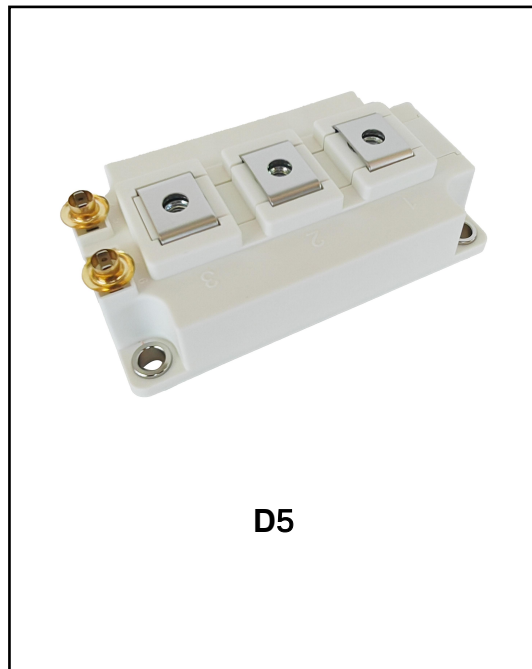
Features

• Electrical features

- $V_{CES} = 1200\text{ V}$
- $I_{C\text{ nom}} = 800\text{ A} / I_{CRM} = 1600\text{ A}$
- V_{CESat} with positive temperature coefficient

• Mechanical features

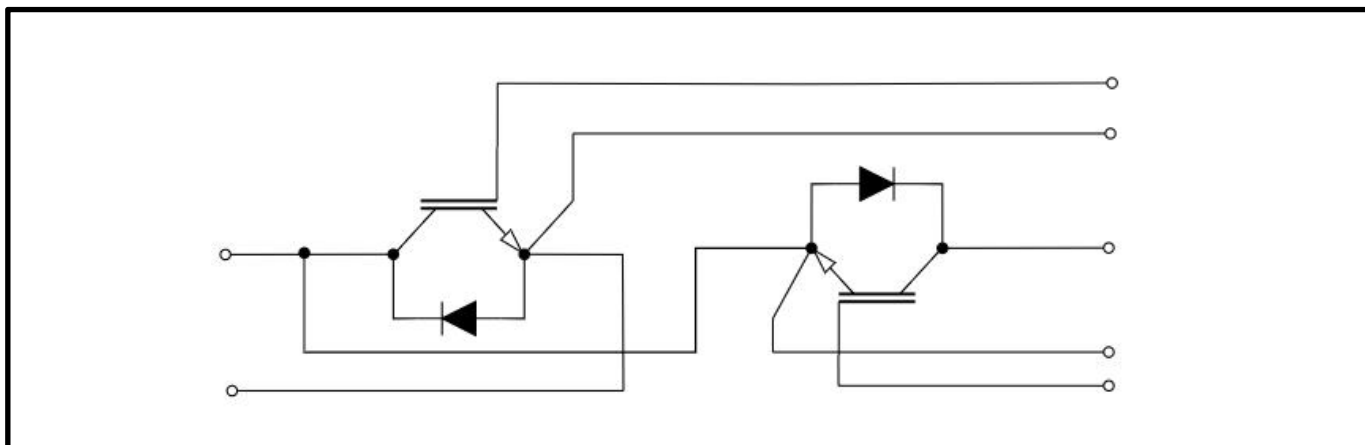
- Standard housing
- 4 kV AC 1 min insulation
- High creepage and clearance distances
- High power density
- Isolated base plate - Package with CTI >400



Typical Applications

- Three-level applications
- Commercial agriculture vehicles
- High-power converters
- Motor drives
- Servo drives
- Solar applications
- UPS systems

Description



Package Insulation coordination

Symbol	Parameter	Note or test condition	Values	Unit
V_{ISOL}	Isolation test voltage	RMS, $f=50\text{Hz}$, $t=60\text{s}$	4.0	kV
d_{creep}	Creepage distance	terminal to heatsink	29.0	mm
d_{creep}	Creepage distance	terminal to terminal	23.0	mm
d_{clear}	Clearance	terminal to heatsink	23.0	mm
d_{clear}	Clearance	terminal to terminal	11.0	mm
CTI	Comparative tracking index (electrical)		>400	

Package Characteristic values

Symbol	Description	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
L_{sCE}	Stray Inductance			--	20	--	nH
$R_{CC'+EE'}$	Module Lead Resistance, Terminal to Chip	$T_c=25^\circ\text{C}$, perswitch		--	0.5	--	m Ω
T_{stg}	Storage temperature			-40	--	125	$^\circ\text{C}$
M	Mounting torque for module mounting	-Mounting according to valid application note	M5, Screw	3.0	--	6.0	Nm
M	Terminal connection torque	-Mounting according to valid application note	M6, Screw	2.5	--	5	Nm
G	Weight			--	340	--	g

Maximum rated values
IGBT

Symbol	Description	Note or test condition		Value	Unit
V_{CES}	Collector-Emitter Voltage	$T_{vj} = 25\text{ }^{\circ}\text{C}$		1200	V
I_{CDC}	Continuous DC collector current	$T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$	$T_C = 90\text{ }^{\circ}\text{C}$	800	A
I_{CRM}	Repetitive peak collector current	t_p limited by $T_{vj\text{ op}}$		1600	A
P_{tot}	Total power dissipation	$T_C = 25\text{ }^{\circ}\text{C}$, $T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$		3488	W
V_{GES}	Gate-emitter peak voltage			± 20	V

Diode

Symbol	Description	Note or test condition		Value	Unit
V_{RRM}	Repetitive peak reverse voltage	$T_{vj} = 25\text{ }^{\circ}\text{C}$		1200	V
I_F	Continuous DC forward current			800	A
I_{FRM}	Repetitive peak forward current	$t_p = 1\text{ ms}$		1600	A

IGBT Characteristics

Symbol	Parameter	Test Condition		Value			Unit
				Min	Typ	Max	
$V_{CE(sat)}$	Collector–Emitter Saturation Voltage	$I_C = 800\text{ A}$, $V_{GE} = 15\text{ V}$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	1.45	1.75	V
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	1.70	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	1.75	--	
$V_{GE(TH)}$	Gate–Emitter Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 16\text{ mA}$, $T_{vj} = 25^{\circ}\text{C}$		4.6	5.2	5.8	V
I_{CES}	Collector–Emitter Cutoff Current	$V_{GE} = 0\text{ V}$, $V_{CE} = 1200\text{ V}$, $T_{vj} = 25^{\circ}\text{C}$		--	--	0.1	mA
I_{GES}	Gate–Emitter Leakage Current	$V_{GE} = 20\text{ V}$, $V_{CE} = 0\text{ V}$, $T_{vj} = 25^{\circ}\text{C}$		--	--	100	nA
R_{Gint}	Internal Gate Resistance	$T_{vj} = 25\text{ }^{\circ}\text{C}$		--	1.34	--	Ω
C_{ies}	Input Capacitance	$f = 100\text{ kHz}$, $T_{vj} = 25\text{ }^{\circ}\text{C}$, $V_{CE} = 25\text{ V}$, $V_{GE} = 0\text{ V}$		--	136	--	nF
C_{res}	Reverse Transfer Capacitance			--	0.48	--	nF
Q_G	Gate Charge	$V_{GE} = \pm 15\text{ V}$, $V_{CC} = 600\text{ V}$		--	4.43	--	μC
$t_{d(on)}$	Turn–On Delay Time	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_G = 1.0\text{ }\Omega$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	0.406	--	μs
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	0.460	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	0.467	--	
t_r	Rise Time	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_G = 1.0\text{ }\Omega$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	0.073	--	μs
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	0.088	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	0.091	--	
$t_{d(off)}$	Turn–off Delay Time	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_{Goff} = 1.0\text{ }\Omega$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	0.825	--	μs
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	0.939	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	0.960	--	
t_f	Fall Time	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_G = 1.0\text{ }\Omega$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	0.100	--	μs
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	0.225	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	0.228	--	
E_{on}	Turn–On Switching Loss per Pulse	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_G = 1.0\text{ }\Omega$ ($T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$)	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	20.6	--	mJ
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	40.8	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	46.8	--	
E_{off}	Turn Off Switching Loss per Pulse	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V} / -5\text{ V}$, $R_G = 1.0\text{ }\Omega$ ($T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$)	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	90.6	--	mJ
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	120.6	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	124.8	--	
I_{SC}	SC Data	$V_{GE} \leq 15\text{ V}$, $V_{CC} = 800\text{ V}$, $V_{CEmax} = V_{CES} - L_{sCE} \cdot di/dt$	$t_P \leq 10\text{ }\mu\text{s}$, $T_{vj} = 150\text{ }^{\circ}\text{C}$	--	4000	--	A
			$t_P \leq 10\text{ }\mu\text{s}$, $T_{vj} = 175\text{ }^{\circ}\text{C}$	--	3768	--	
R_{thJC}	Thermal resistance, junction to case	per IGBT		--	--	0.043	K/W
$T_{vj\text{ op}}$	Temperature under switching conditions			-40	--	175	$^{\circ}\text{C}$

Diode Characteristics

Symbol	Parameter	Test Condition		Value			Unit
				Min	Typ	Max	
V_F	Diode Forward Voltage	$I_F = 800\text{ A}$, $V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	2.25	2.7	V
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	2.05	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	2.00	--	
Q_r	Recovered Charge	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V}$ / -5V, $R_G = 1.0\text{ }\Omega$ ($T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$)	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	27	--	μC
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	51	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	57	--	
I_{RM}	Peak Reverse Recovery Current	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V}$ / -5V, $R_G = 1.0\text{ }\Omega$ ($T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$)	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	560	--	A
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	715	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	740	--	
E_{rec}	Reverse recovery energy	$I_C = 800\text{ A}$, $V_{CC} = 600\text{ V}$, $V_{GE} = 15\text{ V}$ / -5V, $R_G = 1.0\text{ }\Omega$ ($T_{vj\text{ max}} = 175\text{ }^{\circ}\text{C}$)	$T_{vj} = 25\text{ }^{\circ}\text{C}$	--	17.5	--	mJ
			$T_{vj} = 150\text{ }^{\circ}\text{C}$	--	48.3	--	
			$T_{vj} = 175\text{ }^{\circ}\text{C}$	--	55.9	--	
R_{thJC}	Thermal resistance, junction to case	per diode		--	--	0.081	K/W
$T_{vj\text{ op}}$	Temperature under switching conditions			-40	--	175	$^{\circ}\text{C}$

Figure 1.Output characteristic (typical),IGBT, Inverter
 $V_{GE}=15V$

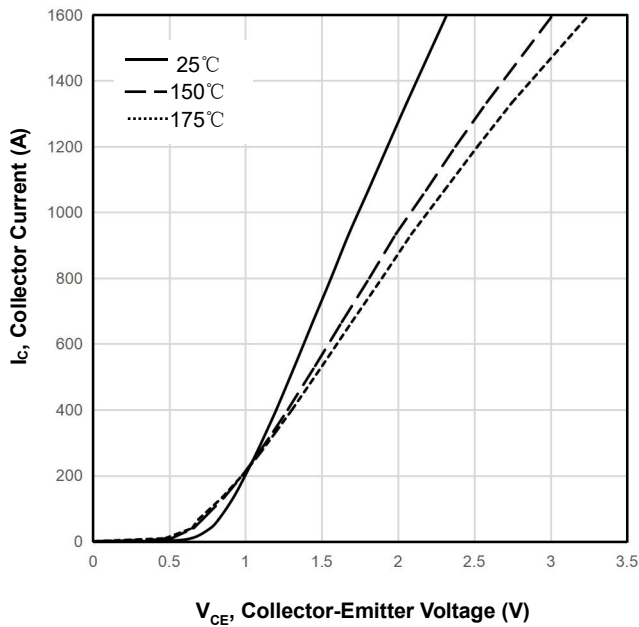


Figure 2.Output characteristic IGBT, Inverter (typical)
 $T_{vj}=175^{\circ}C$

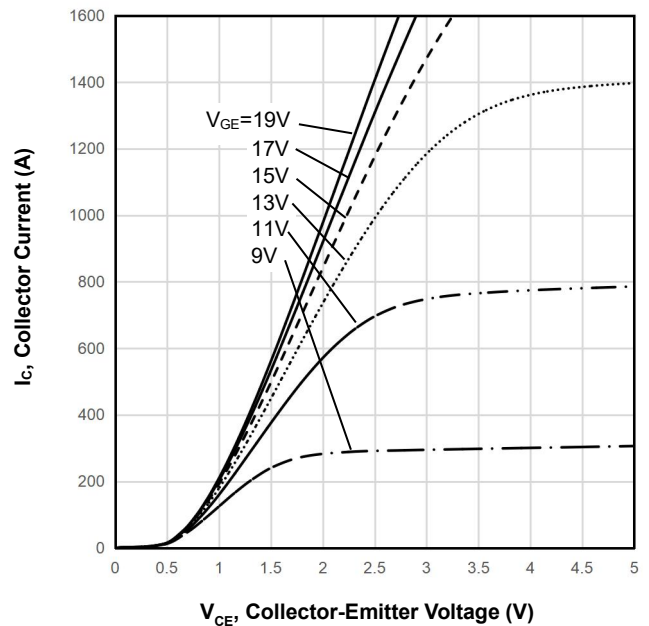


Figure 3.Transfer characteristic (typical), IGBT, Inverter
 $V_{CE}=60V$

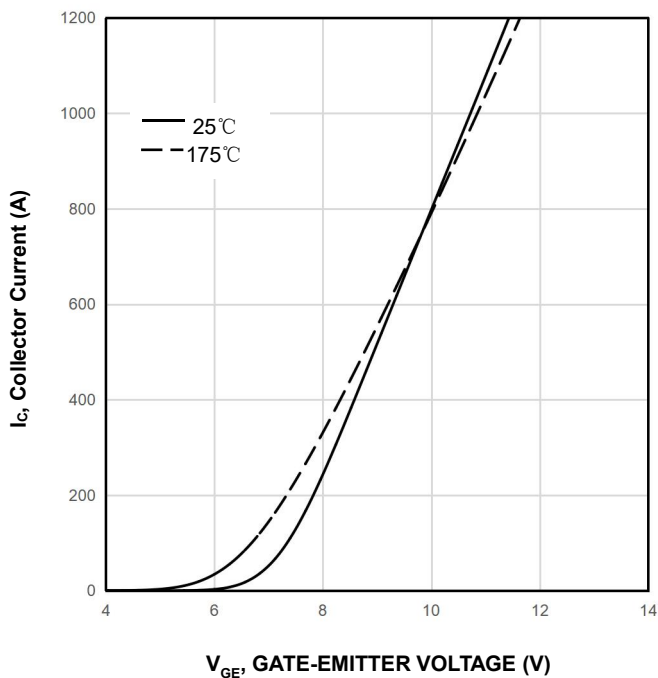


Figure 4.Switching losses (typical), IGBT, Inverter
 $V_{CE}=600V, V_{GE}=15/-5V, R_G=1.0\Omega$

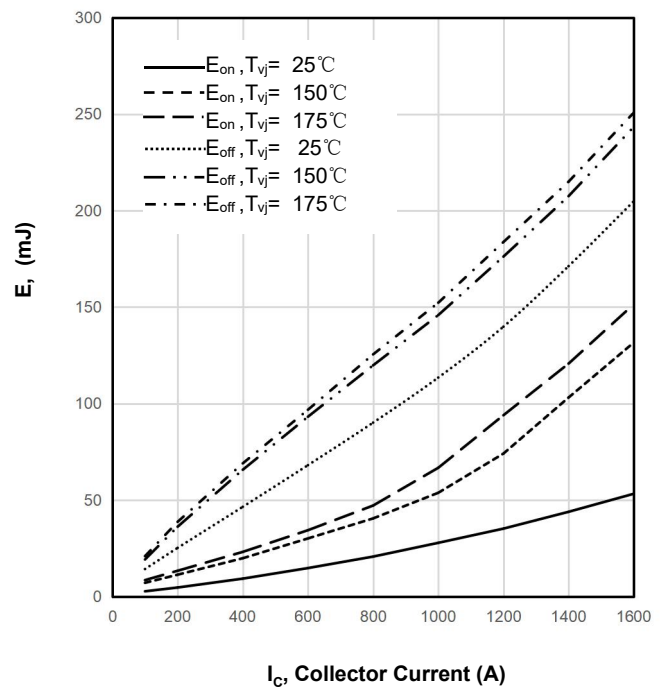


Figure 5. Switching losses (typical), IGBT, Inverter
 $V_{CE}=600V, V_{GE}=15/-5V, I_C=800A$

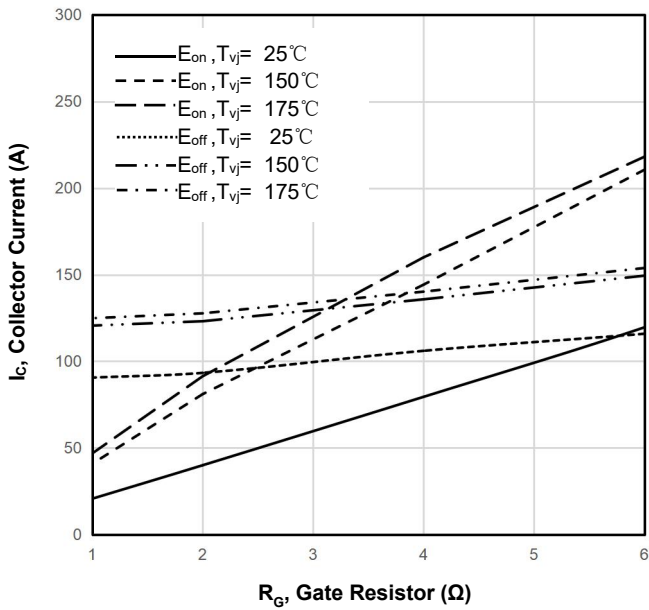


Figure 6. Switching times (typical), IGBT, Inverter
 $V_{CE}=600V, V_{GE}=15/-5V, R_G=1.0\Omega, T_{vj}=175^\circ C$

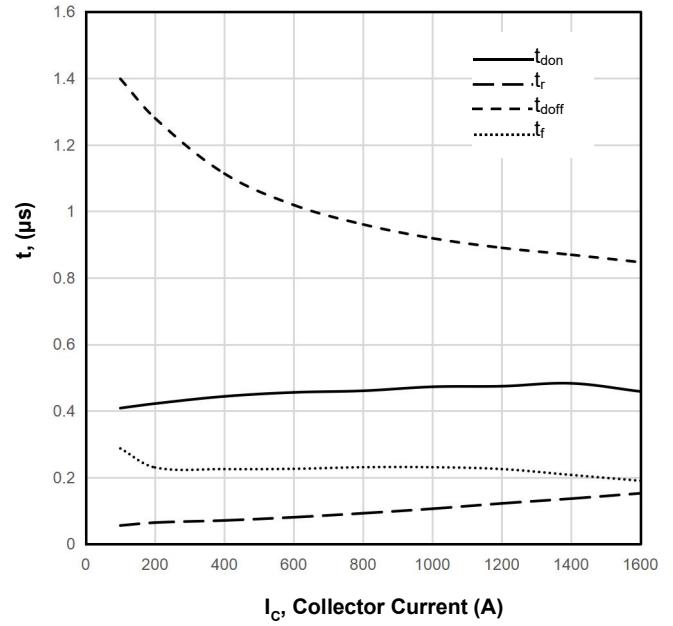


Figure 7. Switching times (typical), IGBT, Inverter
 $V_{CE}=600V, V_{GE}=15/-5V, I_C=800A, T_{vj}=175^\circ C$

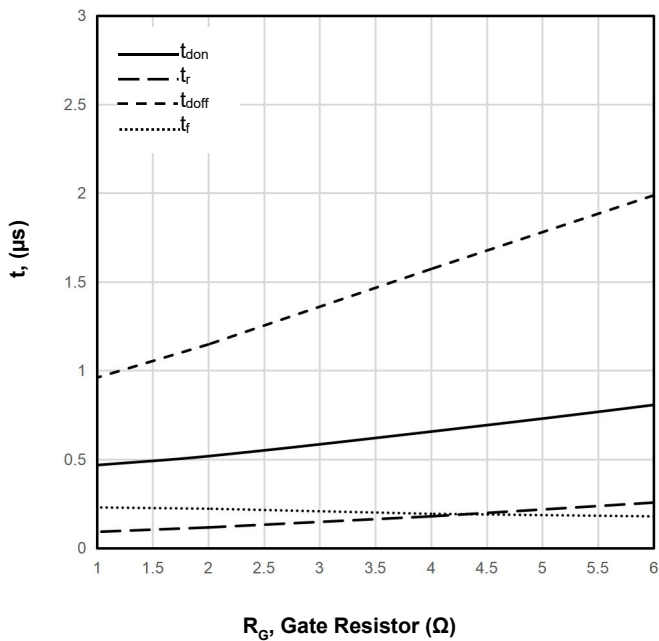


Figure 8. Transient thermal impedance, IGBT, Inverter

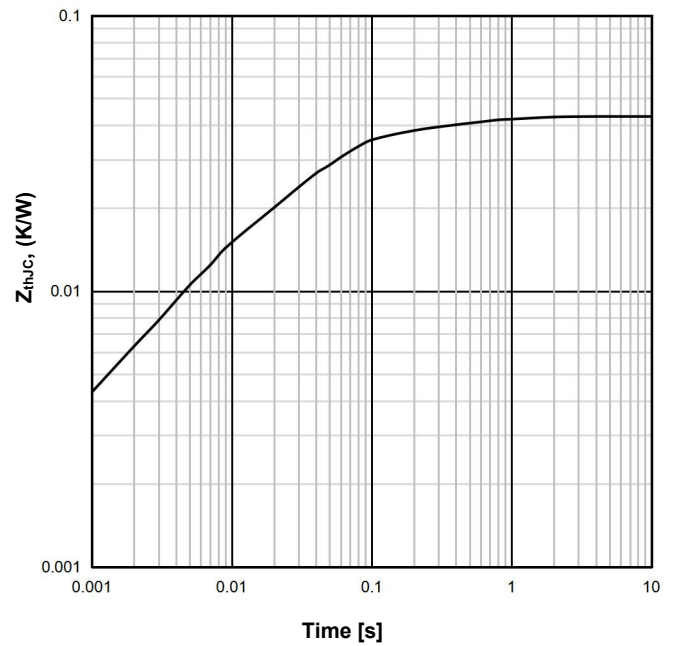


Figure 9.Reverse bias safe operating area , IGBT, Inverter
 $V_{GE}=15/-5V, R_G=25\Omega, T_{vj}= 150^\circ C$

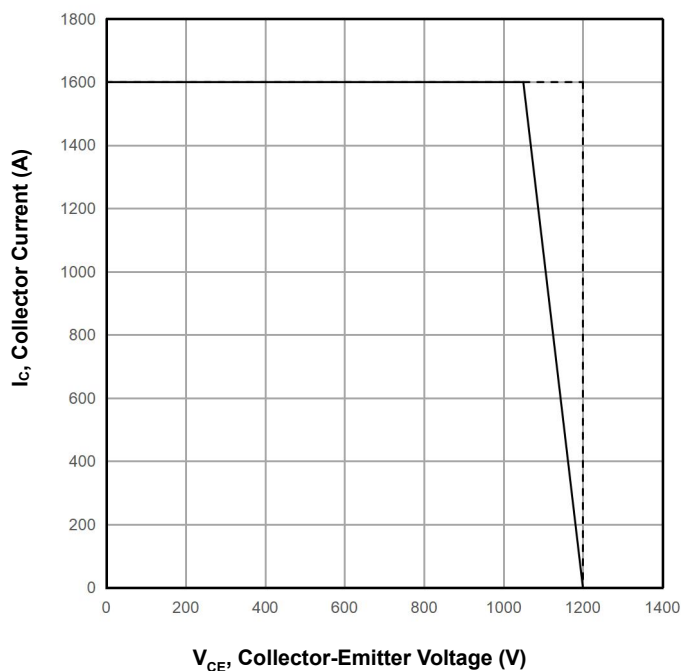


Figure 10.Capacity characteristic (typical), IGBT, Inverter
 $f = 100 \text{ kHz}, V_{GE}=0V, T_{vj}= 25^\circ C$

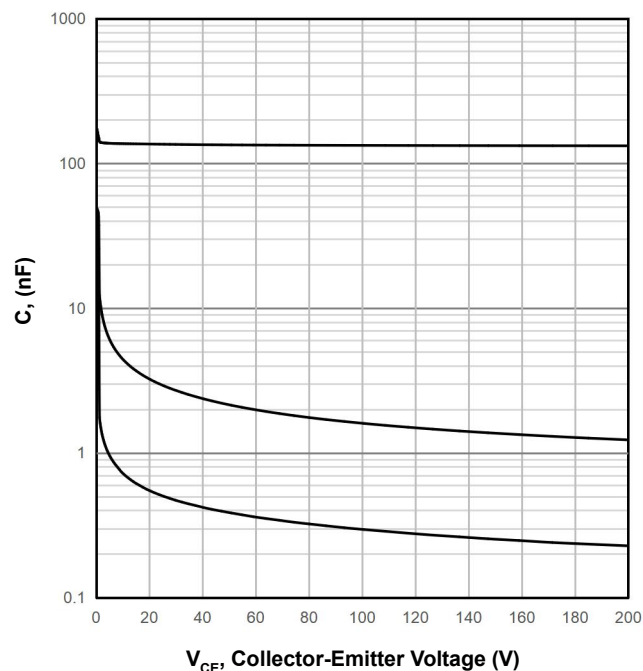


Figure 11.Forward characteristic (typical), Diode, Inverter

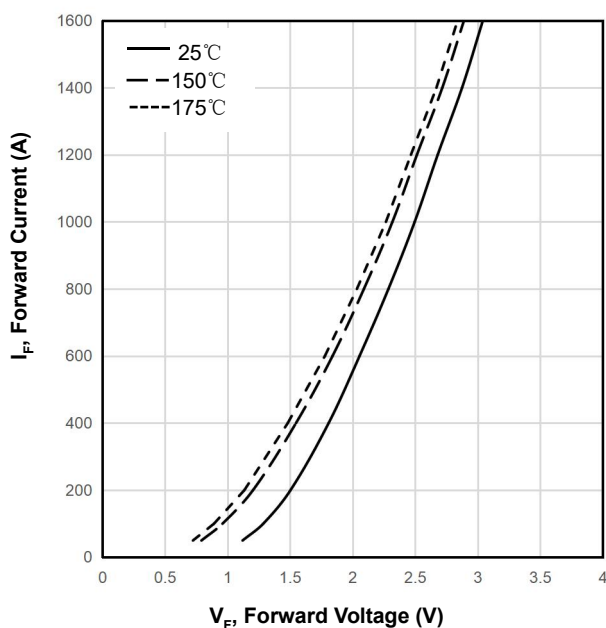


Figure 12.Switching losses (typical), Diode, Inverter
 $V_{CE}=600V, R_G=1.0\Omega$

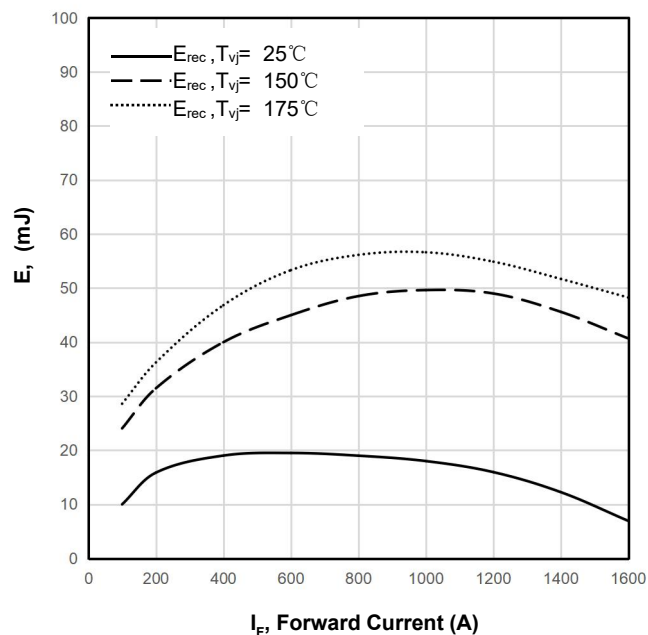


Figure 13. Switching losses (typical), Diode, Inverter
 $V_{CE}=600V, I_F=800A$

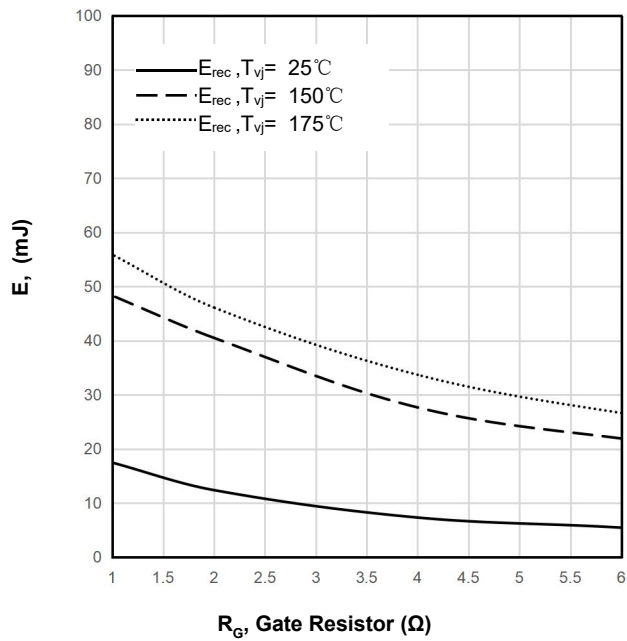
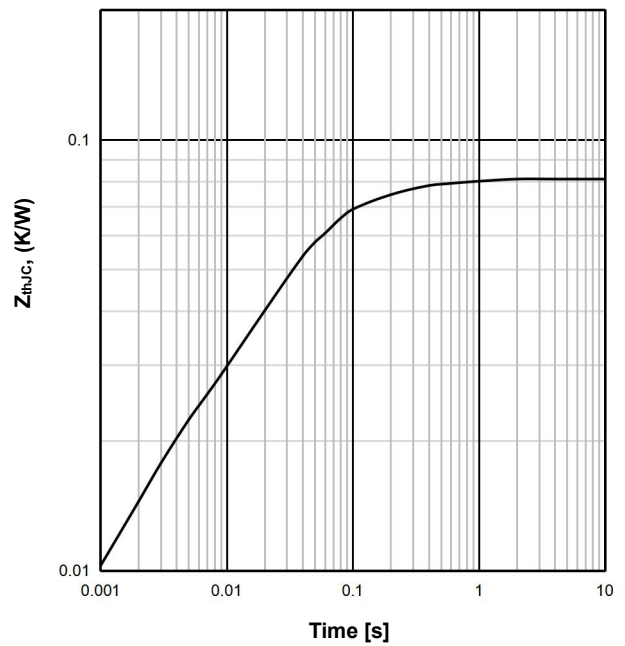
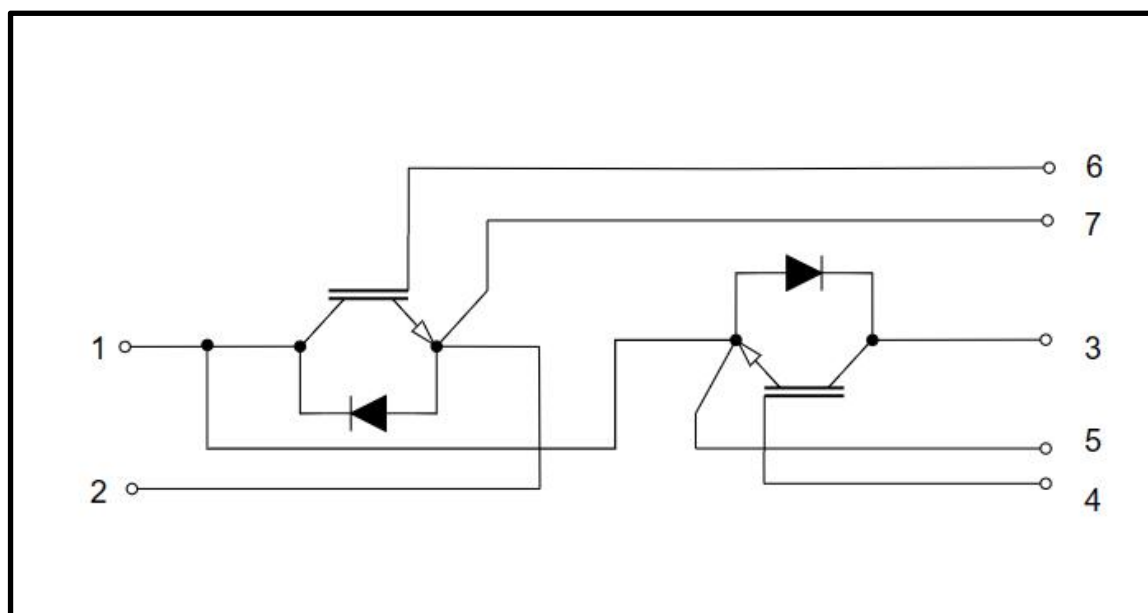


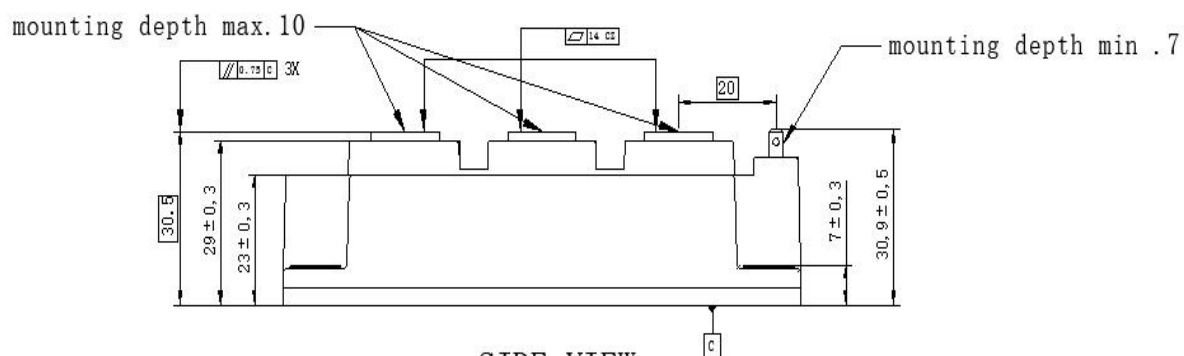
Figure 14. Transient thermal impedance, Diode, Inverter



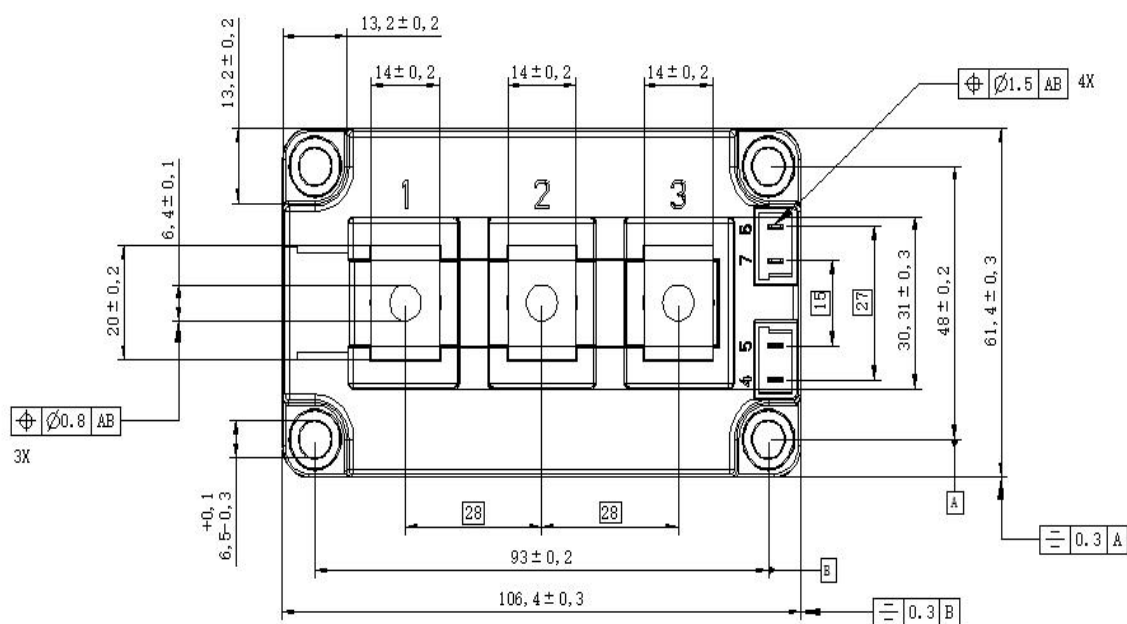
CIRCUIT DIAGRAM



PACKAGE DIMENSION



SIDE VIEW



TOP VIEW